

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	09/682,659	HEY, JOHN	
	Examiner	Art Unit	
	Lee Fineman	2872	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted A. Chang (AU 2872) for search	12/6/2002	LAF
EAST search attached	12/9/2002	LAF
EAST search (see search history printout)	2/16/2006	LAF